Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/662,386	HAYASHI, KENJI
Examiner	Art Unit
Lana N. Le	2685

SEARCHED						
Class	Subclass	Date	Examiner			
455	73	2/5/2006	L.L.			
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consulted with: Vo, Nguyen			
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